

Search Notes

Application/Control No.

10/553,963

Examiner

RIP A. LEE

Applicant(s)/Patent under
Reexamination

ASHIURA ET AL.

Art Unit

1796

SEARCHED

Class	Subclass	Date	Examiner
524	495	4/15/2008	RL
524	577	4/15/2008	RL
524	575	4/15/2008	RL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	4/15/2008	RL
Google-online literature search	4/15/2008	RL
WEBCrawler-online literature search	4/15/2008	RL
ACS Journals database	4/15/2008	RL